

## OptiMOS™ Buck converter series

### Feature

- N-Channel
- Logic Level
- Excellent Gate Charge x  $R_{DS(on)}$  product (FOM)
- 175°C operating temperature
- dv/dt rated
- Ideal for fast switching buck converters
- Pb-free lead plating, RoHS compliant

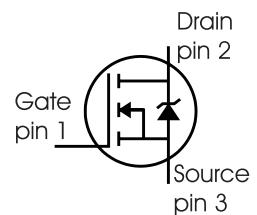
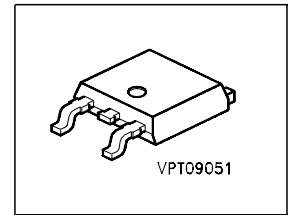


Type	Package	Marking
IPD20N03L G	PG-T0252-3	20N03L

### Product Summary

$V_{DS}$	30	V
$R_{DS(on)}$	20	$\text{m}\Omega$
$I_D$	30	A

PG-T0252-3



### Maximum Ratings, at $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_C=25^\circ\text{C}$	$I_D$	30	A
$T_C=100^\circ\text{C}$		25	
Pulsed drain current $T_C=25^\circ\text{C}$	$I_{D \text{ puls}}$	120	
Avalanche energy, single pulse $I_D=15\text{A}, V_{DD}=25\text{V}, R_{GS}=25\Omega$	$E_{AS}$	15	mJ
Reverse diode dv/dt $I_S=30\text{A}, V_{DS}=24\text{V}, di/dt=200\text{A}/\mu\text{s}, T_{jmax}=175^\circ\text{C}$	dv/dt	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C=25^\circ\text{C}$	$P_{\text{tot}}$	42	W
Operating and storage temperature	$T_j, T_{stg}$	-55... +175	°C
IEC climatic category; DIN IEC 68-1		55/175/56	

**Thermal Characteristics**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Characteristics</b>					
Thermal resistance, junction - case	$R_{thJC}$	-	-	3.6	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	100	
SMD version, device on PCB: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>1)</sup>	$R_{thJA}$	-	-	75	
		-	-	50	

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Static Characteristics</b>					
Drain-source breakdown voltage $V_{GS}=0\text{V}, I_D=1\text{mA}$	$V_{(BR)DSS}$	30	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=25\mu\text{A}$	$V_{GS(\text{th})}$	1.2	1.6	2	
Zero gate voltage drain current $V_{DS}=30\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$ $V_{DS}=30\text{V}, V_{GS}=0\text{V}, T_j=125^\circ\text{C}$	$I_{DSS}$	-	0.01	1	$\mu\text{A}$
-		-	10	100	
Gate-source leakage current $V_{GS}=20\text{V}, V_{DS}=0\text{V}$	$I_{GSS}$	-	1	100	nA
Drain-source on-state resistance $V_{GS}=4.5\text{V}, I_D=15\text{A}$	$R_{DS(\text{on})}$	-	23.0	31	$\text{m}\Omega$
Drain-source on-state resistance $V_{GS}=10\text{V}, I_D=15\text{A}$	$R_{DS(\text{on})}$	-	15.3	20	

<sup>1)</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Conditions</b>	<b>Values</b>			<b>Unit</b>
			<b>min.</b>	<b>typ.</b>	<b>max.</b>	

**Dynamic Characteristics**

Transconductance	$g_{fs}$	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 25\text{A}$	14	28	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{MHz}$	-	560	695	pF
Output capacitance	$C_{oss}$		-	230	280	
Reverse transfer capacitance	$C_{rss}$		-	62	93	
Gate resistance	$R_G$		-	1.3	-	$\Omega$
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 15\text{V}$ , $V_{GS} = 10\text{V}$ , $I_D = 15\text{A}$ , $R_G = 12.7\Omega$	-	6.2	9.3	ns
Rise time	$t_r$		-	31	47	
Turn-off delay time	$t_{d(off)}$		-	23	34	
Fall time	$t_f$		-	18	27	

**Gate Charge Characteristics**

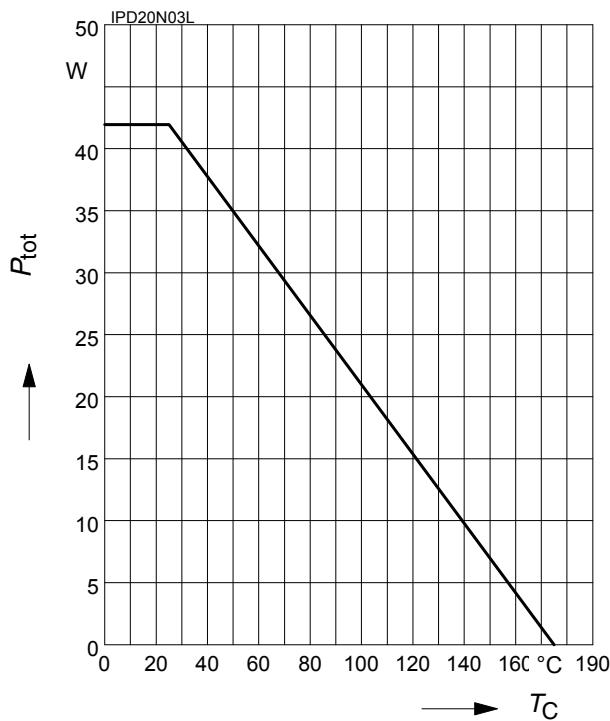
Gate to source charge	$Q_{gs}$	$V_{DD} = 15\text{V}$ , $I_D = 15\text{A}$	-	2.5	3.1	nC
Gate to drain charge	$Q_{gd}$		-	6.4	9.6	
Gate charge total	$Q_g$	$V_{DD} = 15\text{V}$ , $I_D = 15\text{A}$ , $V_{GS} = 0$ to $5\text{V}$	-	15	19	
Output charge	$Q_{oss}$	$V_{DS} = 15\text{V}$ , $I_D = 15\text{A}$ , $V_{GS} = 0\text{V}$	-	8	10	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 15\text{V}$ , $I_D = 15\text{A}$	-	3.6	-	V

**Reverse Diode**

Inverse diode continuous forward current	$I_S$	$T_C = 25^\circ\text{C}$	-	-	30	A
Inverse diode direct current, pulsed	$I_{SM}$		-	-	120	
Inverse diode forward voltage	$V_{SD}$	$V_{GS} = 0\text{V}$ , $I_F = 30\text{A}$	-	1.1	1.4	V
Reverse recovery time	$t_{rr}$	$V_R = 15\text{V}$ , $I_F = 5\text{A}$ , $dI_F/dt = 100\text{A}/\mu\text{s}$	-	26	32	ns
Reverse recovery charge	$Q_{rr}$		-	13	16	nC

## 1 Power dissipation

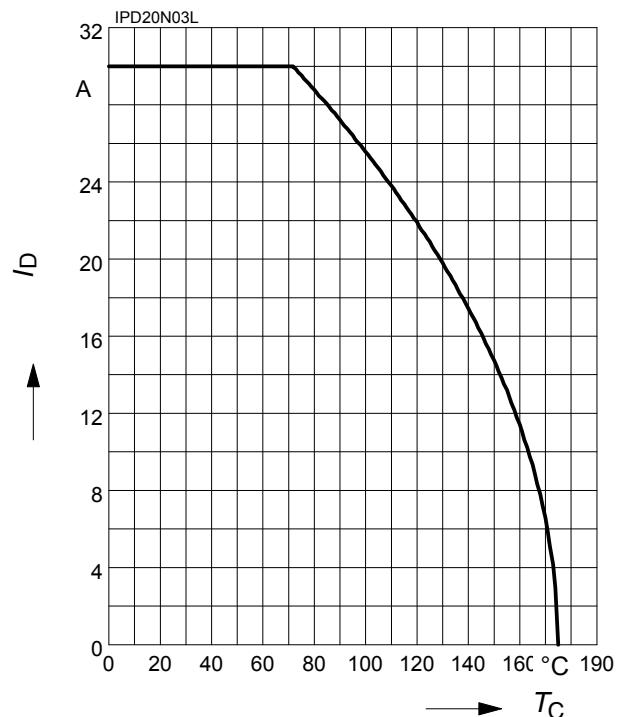
$$P_{\text{tot}} = f(T_C)$$



## 2 Drain current

$$I_D = f(T_C)$$

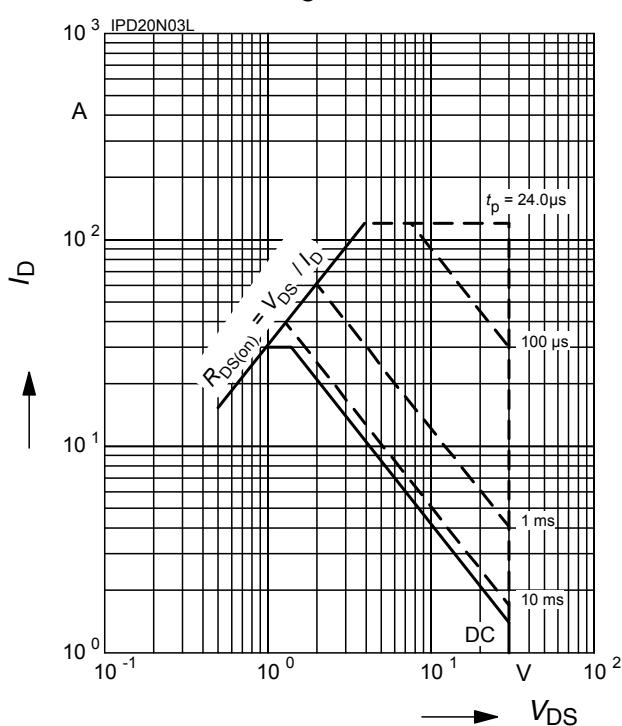
parameter:  $V_{GS} \geq 10$  V



## 3 Safe operating area

$$I_D = f(V_{DS})$$

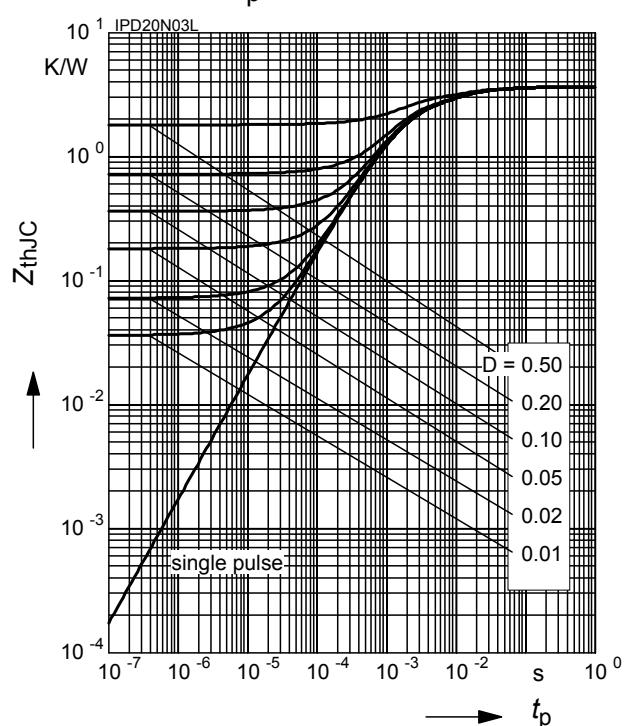
parameter :  $D = 0$  ,  $T_C = 25$  °C



## 4 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

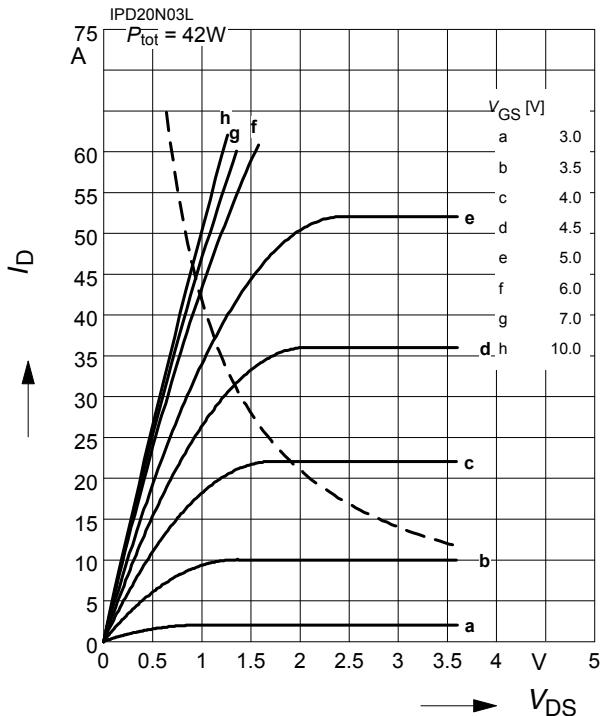
parameter :  $D = t_p/T$



### 5 Typ. output characteristic

$$I_D = f(V_{DS}); \quad T_j=25^\circ\text{C}$$

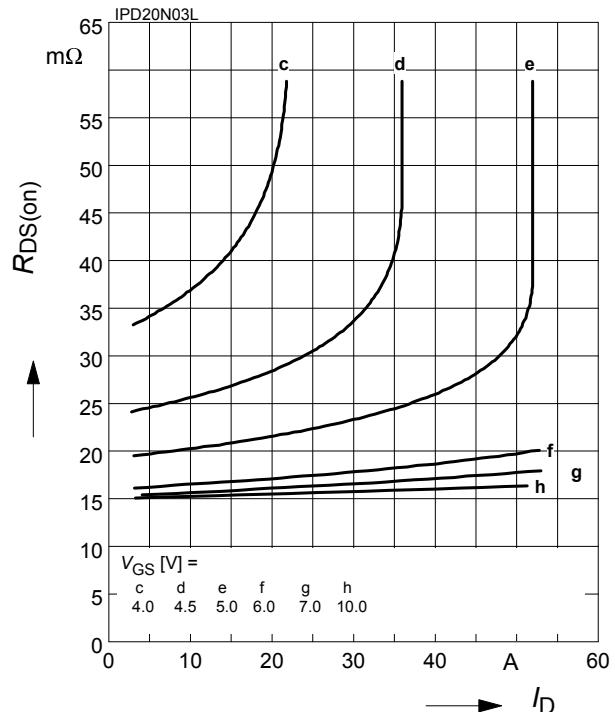
parameter:  $t_p = 80 \mu\text{s}$



### 6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

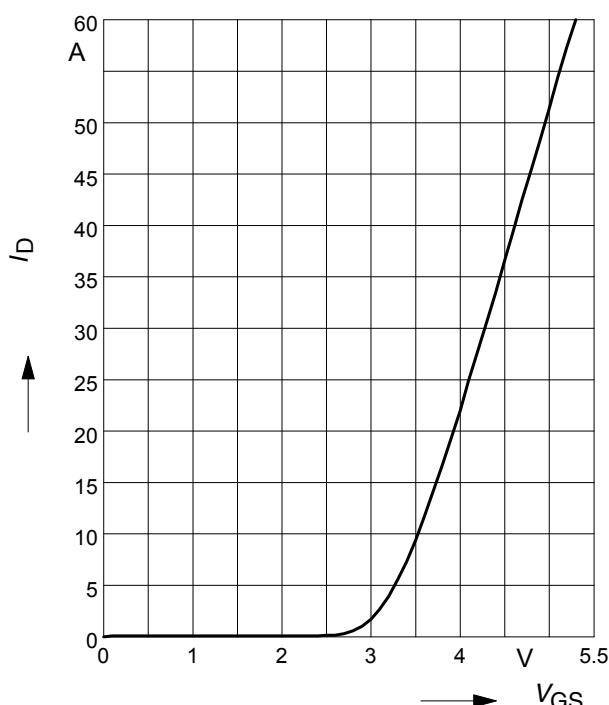
parameter:  $V_{GS}$



### 7 Typ. transfer characteristics

$$I_D = f(V_{GS}); \quad V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$$

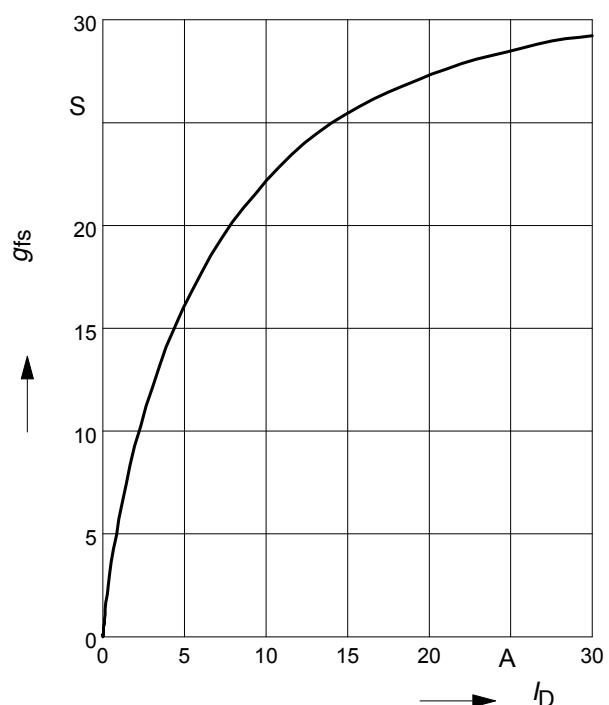
parameter:  $t_p = 80 \mu\text{s}$



### 8 Typ. forward transconductance

$$g_{fs} = f(I_D); \quad T_j=25^\circ\text{C}$$

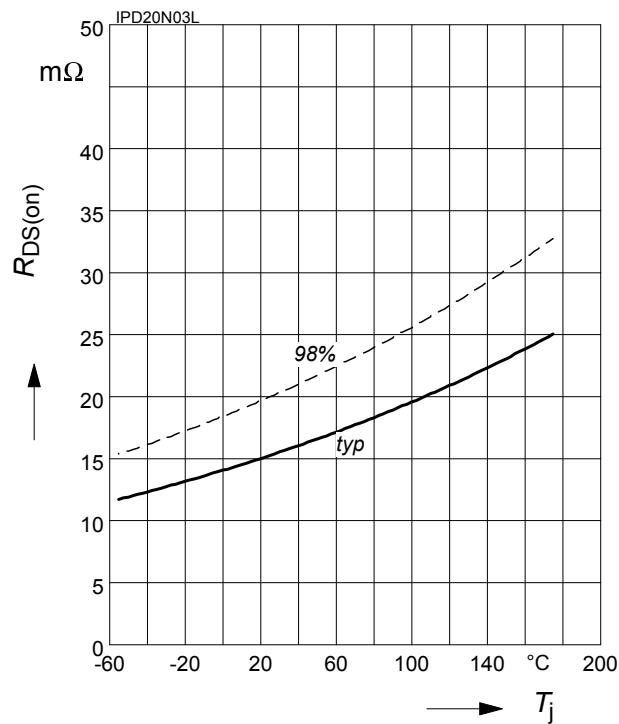
parameter:  $g_{fs}$



## 9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

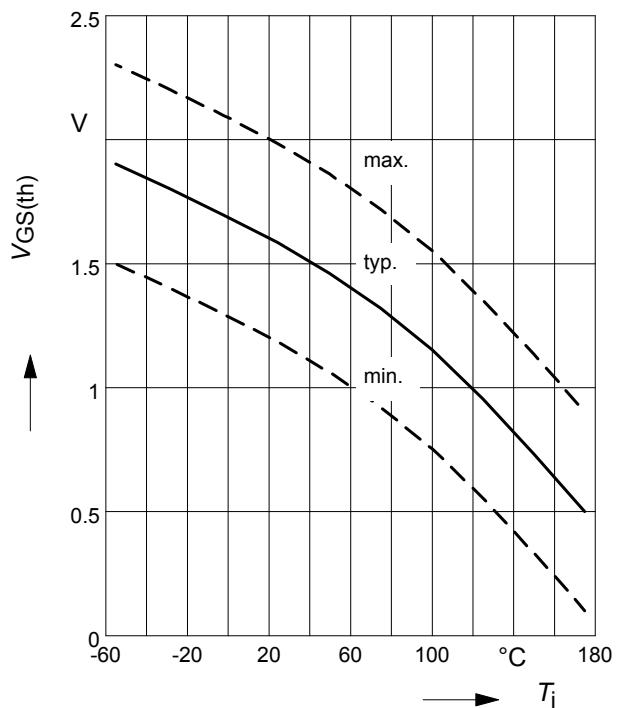
parameter:  $I_D = 15 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



## 10 Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

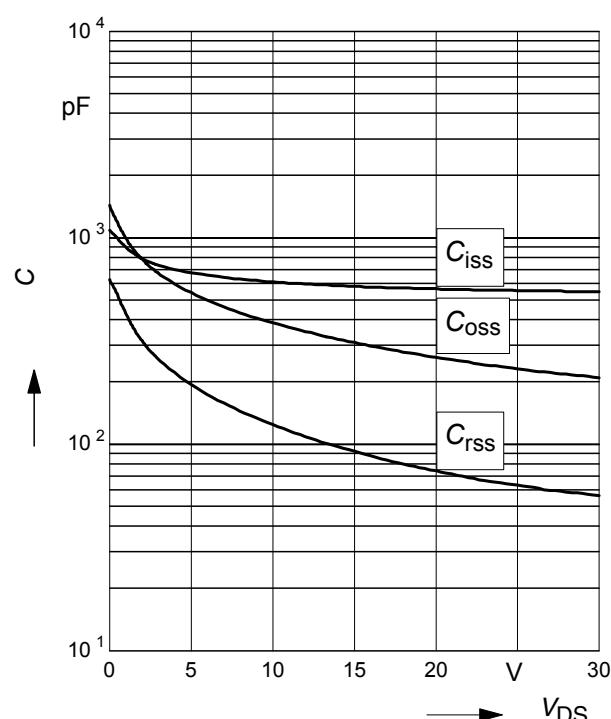
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 25 \mu\text{A}$



## 11 Typ. capacitances

$$C = f(V_{DS})$$

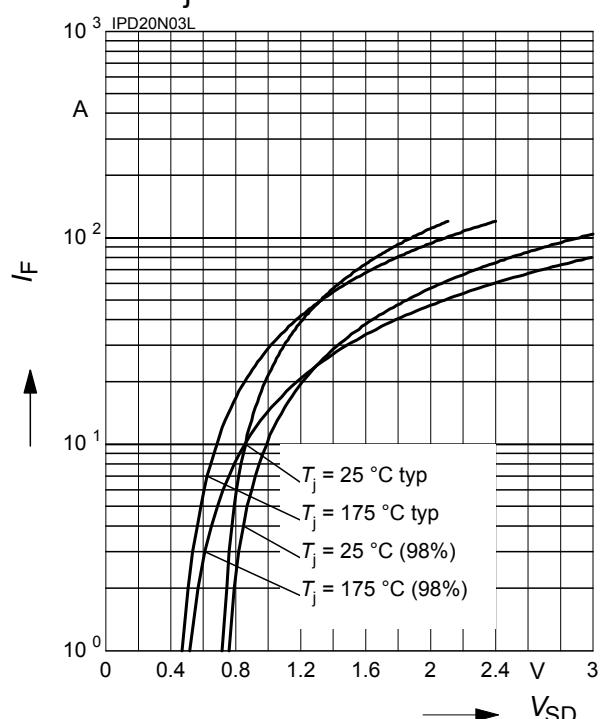
parameter:  $V_{GS}=0\text{V}$ ,  $f=1 \text{ MHz}$



## 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

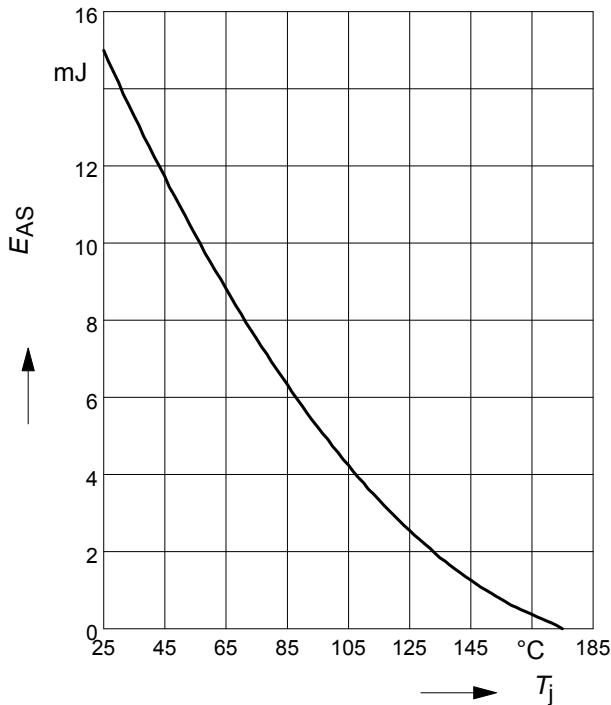
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



### 13 Typ. avalanche energy

$$E_{AS} = f(T_j)$$

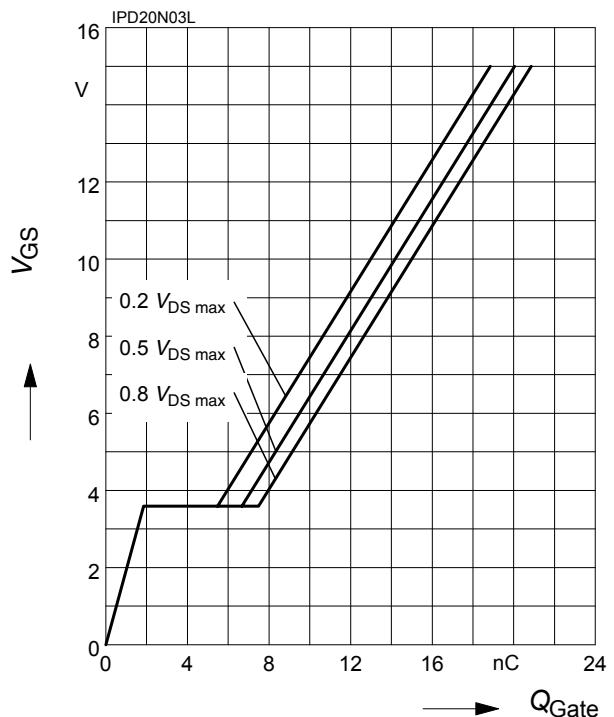
par.:  $I_D = 15 \text{ A}$ ,  $V_{DD} = 25 \text{ V}$ ,  $R_{GS} = 25 \Omega$



### 14 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

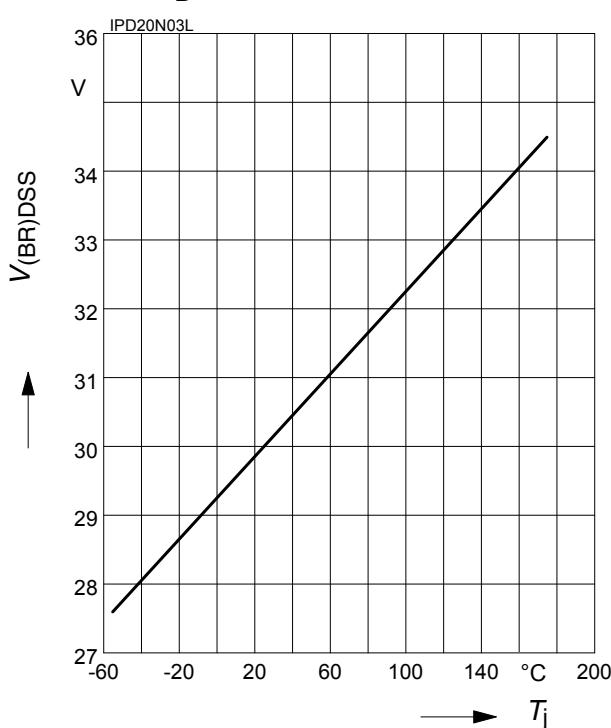
parameter:  $I_D = 30 \text{ A}$  pulsed



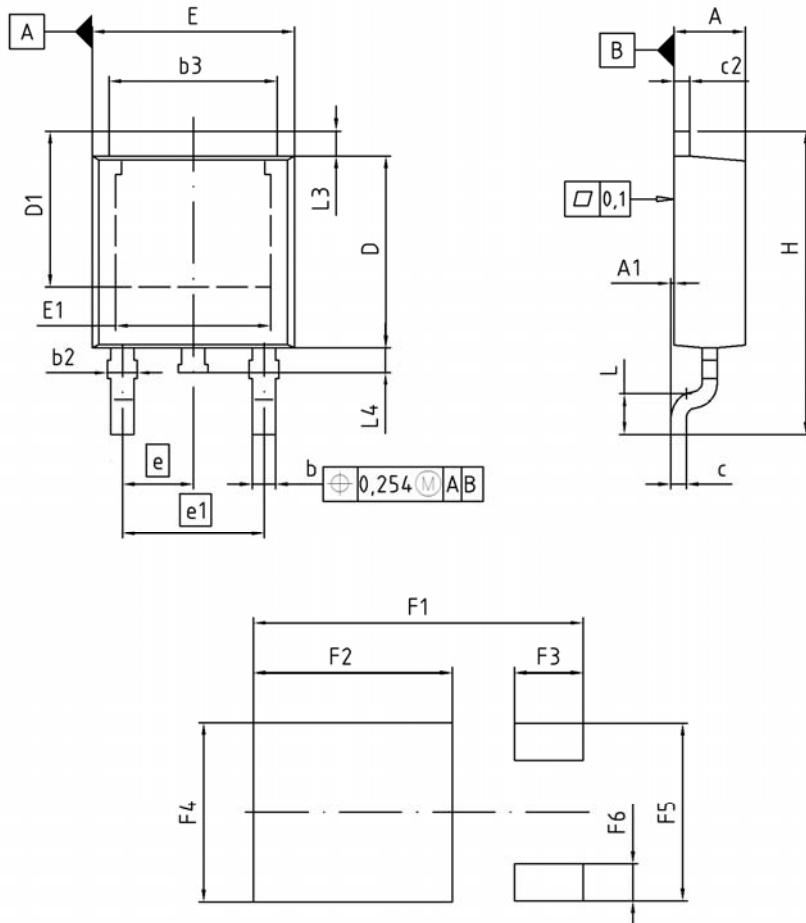
### 15 Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$

parameter:  $I_D=10 \text{ mA}$



## Package outline: PG-T0252-3



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.00	0.15	0.000	0.006
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b3	5.00	5.50	0.197	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.98	0.018	0.039
D	5.97	6.22	0.235	0.245
D1	5.02	5.84	0.198	0.230
E	6.40	6.73	0.252	0.265
E1	4.70	5.21	0.185	0.205
e	2.29		0.090	
e1	4.57		0.180	
N	3		3	
H	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L3	0.90	1.25	0.035	0.049
L4	0.51	1.00	0.020	0.039
F1	10.50	10.70	0.413	0.421
F2	6.30	6.50	0.248	0.256
F3	2.10	2.30	0.083	0.091
F4	5.70	5.90	0.224	0.232
F5	5.66	5.86	0.223	0.231
F6	1.10	1.30	0.043	0.051

DOCUMENT NO.	Z8B00003328
SCALE	0 2.0 0 2.0 4mm
EUROPEAN PROJECTION	
ISSUE DATE	19-10-2007
REVISION	03

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**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**  
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